

Features

- Temperature-compensated: 30 ppm/ $^{\circ}\text{C}$
- Trimmed bandgap reference
- Internal amplifier with 150 mA capability
- Multiple temperature ranges
- Low frequency dynamic output impedance: < 150 m Ω
- Low output noise
- Robust ESD protection

Description

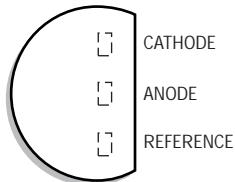
The AS431 is a three-terminal adjustable shunt regulator providing a highly accurate bandgap reference. The adjustable shunt regulator is ideal for a wide variety of linear applications that can be implemented using external components to obtain adjustable currents and voltages.

In the standard shunt configuration, the combination of low temperature coefficient (TC), sharp turn-on characteristics, low output impedance and programmable output voltage make this precision reference a perfect zener diode replacement.

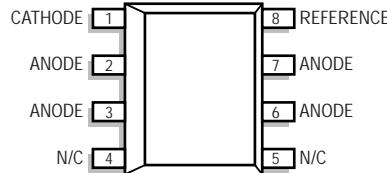
The AS431 precision adjustable shunt reference is offered in four bandgap tolerances: $\pm 0.25\%$, $\pm 0.5\%$, $\pm 1.0\%$, and $\pm 2.0\%$.

Pin Configuration – Top View

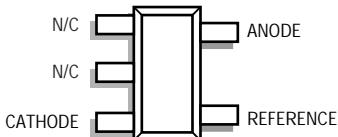
TO-92 (LP)



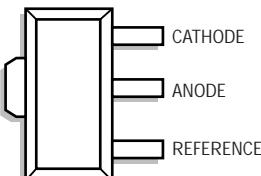
8L SOIC (8D)



5L SOT-23 (5VS)



SOT-89 (S)



Ordering Information

AS431 - A B 8D N

Circuit Type: _____
Precision Adjustable
Shunt Regulator

Bandgap Tolerance: _____
A = $\pm 0.25\%$
C = $\pm 0.5\%$
D = $\pm 1.0\%$
E = $\pm 2.0\%$

Temperature Range: _____
A = 0°C to 70°C
B = 0°C to 105°C
C = -40°C to $+85^{\circ}\text{C}$

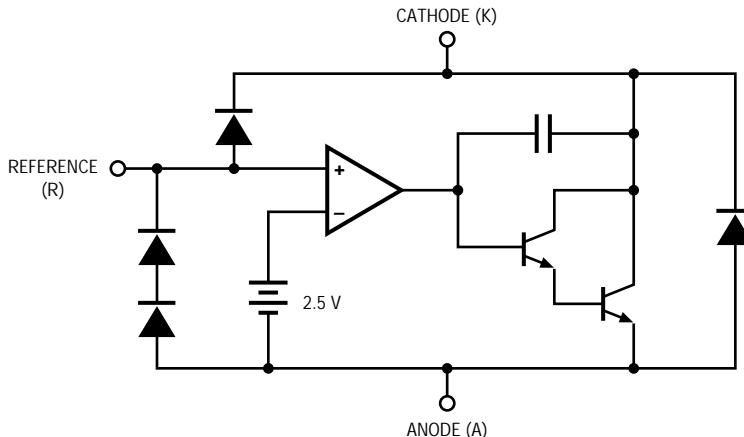
Packaging Option:

A = Ammo Pack
B = Bulk
T = Tube
M = Tape and Reel (7" Reel Dia. SOT-23 Only)
N = Tape and Reel (13" Reel Dia.)

Package Style:

8D = 8 Pin, Plastic SOIC
5VS = 5 Pin, SOT-23
LP = TO-92
S = SOT-89

Functional Block Diagram



Absolute Maximum Ratings

Parameter	Symbol	Rating	Units
Cathode-Anode Reverse Breakdown	V_{KA}	37	V
Anode-Cathode Forward Current	I_{AK}	1	A
Operating Cathode Current	I_{KA}	250	mA
Reference Input Current	I_{REF}	10	mA
Continuous Power at 25°C	P_D		
TO-92		775	mW
8L SOIC		750	mW
SOT-89		1000	mW
5L SOT-23		200	mW
Junction Temperature	T_J	150	°C
Storage Temperature	T_{STG}	-65 to 150	°C
Lead Temperature, Soldering 10 Seconds	T_L	300	°C

Stresses greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

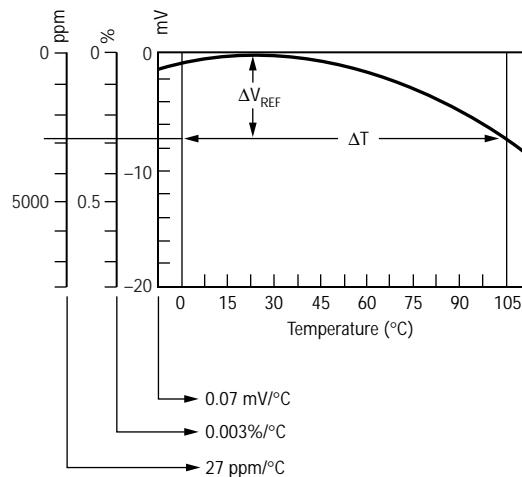
Recommended Conditions

Parameter	Symbol	Rating	Unit
Cathode Voltage	V_{KA}	V_{REF} to 20	V
Cathode Current	I_K	10	mA

Typical Thermal Resistances

Package	θ_{JA}	θ_{JC}	Typical Derating
TO-92	160°C/W	80°C/W	6.3 mW/°C
SOIC	175°C/W	45°C/W	5.7 mW/°C
SOT-89	110°C/W	8°C/W	9.1 mW/°C
SOT-23/5L	575°C/W	150°C/W	1.7 mW/°C

Average Temperature Coefficient



$$\bullet \text{ TC in } \text{mV/}^{\circ}\text{C} = \frac{\Delta V_{\text{REF}} (\text{mV})}{\Delta T_A}$$

$$\bullet \text{ TC in } \%/\text{ }^{\circ}\text{C} = \frac{\left(\frac{\Delta V_{\text{REF}}}{V_{\text{REF}} \text{ at } 25^{\circ}\text{C}} \right) \times 100}{\Delta T_A}$$

$$\bullet \text{ TC in } \text{ppm/}^{\circ}\text{C} = \frac{\left(\frac{\Delta V_{\text{REF}}}{V_{\text{REF}} \text{ at } 25^{\circ}\text{C}} \right) \times 10^6}{\Delta T_A}$$

Test Circuits

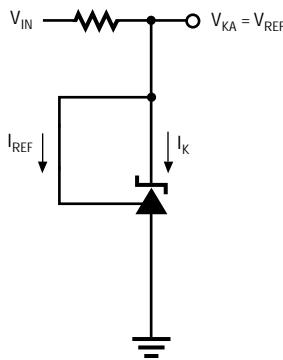


Figure 1a. Test Circuit 1

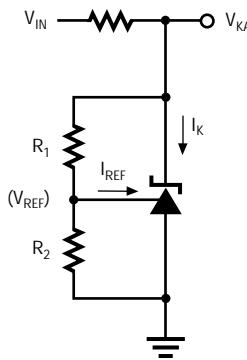


Figure 1b. Test Circuit 2

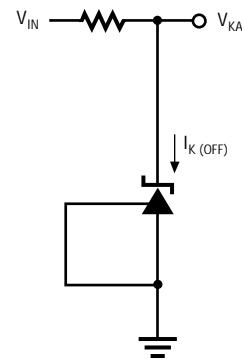


Figure 1c. Test Circuit 3

Typical Performance Curves

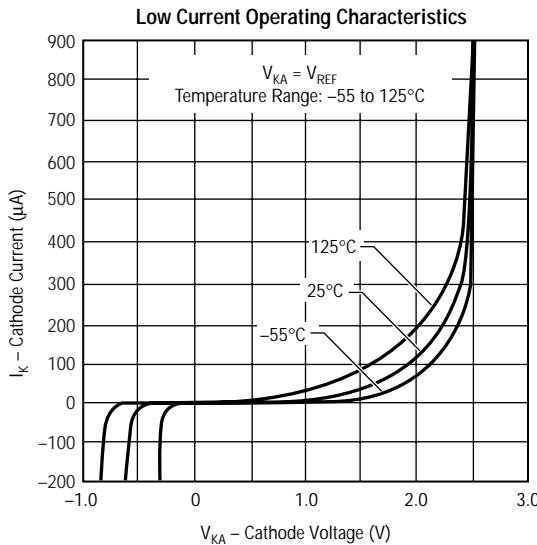


Figure 2

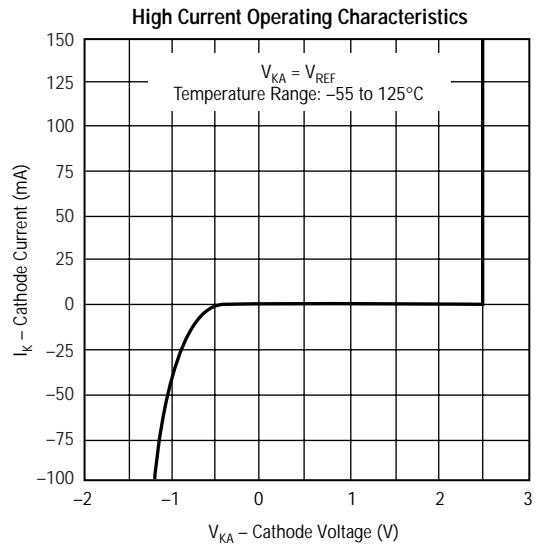


Figure 3

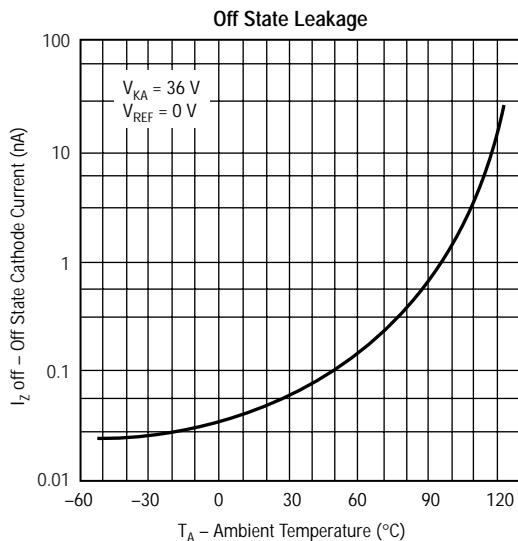


Figure 4

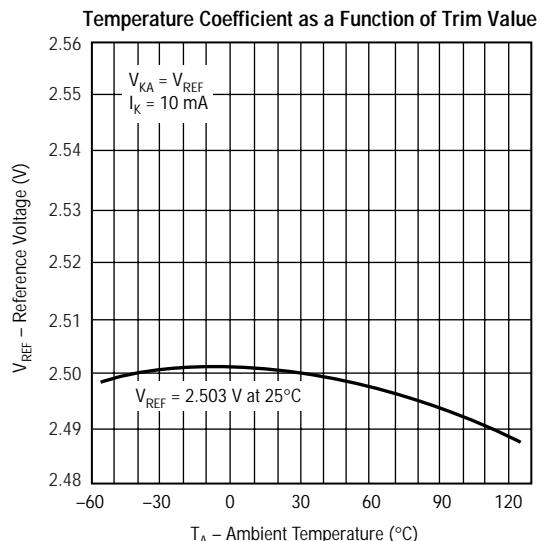


Figure 5

Typical Performance Curves

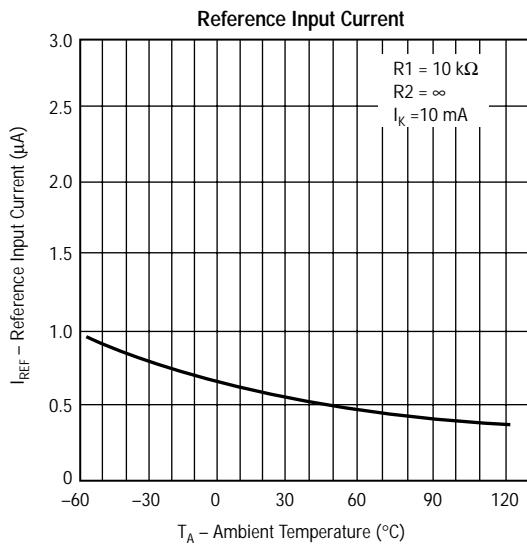


Figure 6

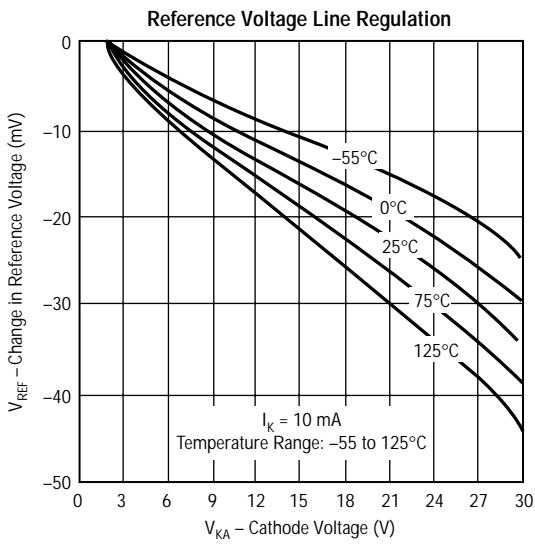


Figure 7

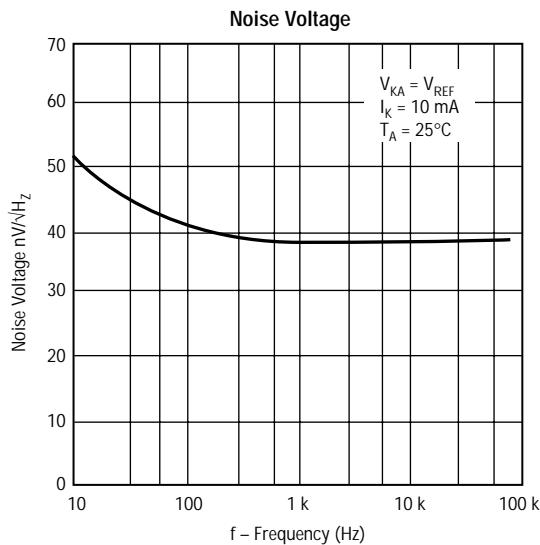


Figure 8

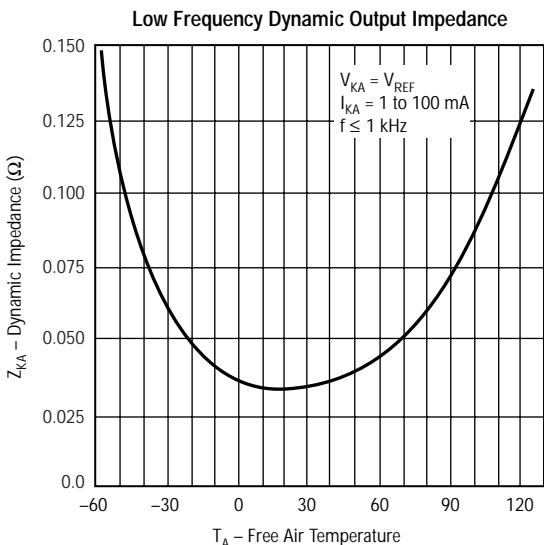


Figure 9

Typical Performance Curves

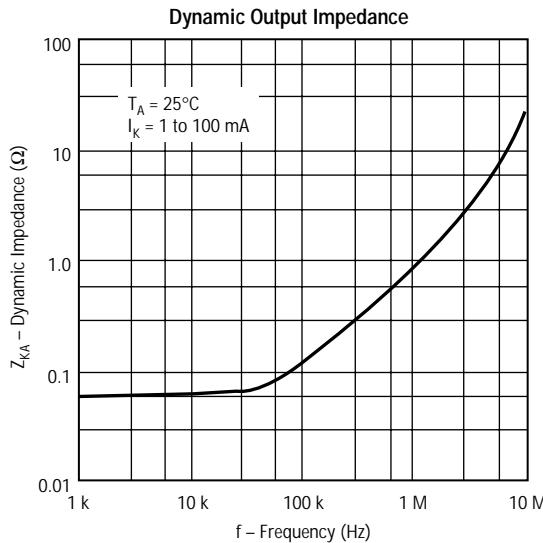


Figure 10

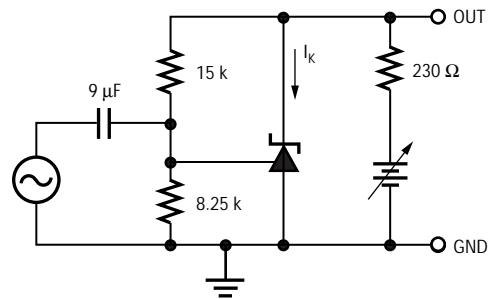
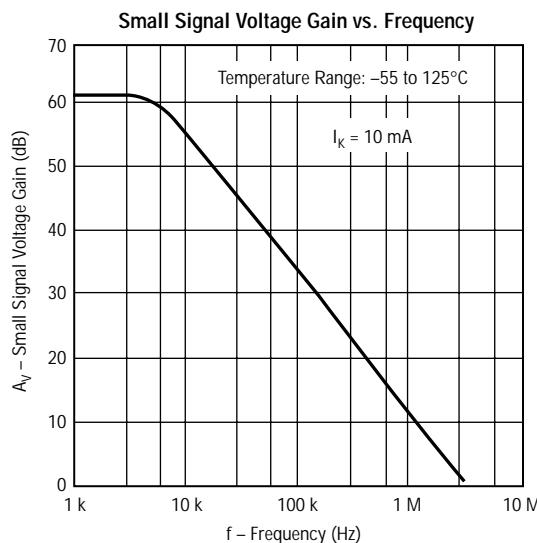


Figure 11

Typical Performance Curves

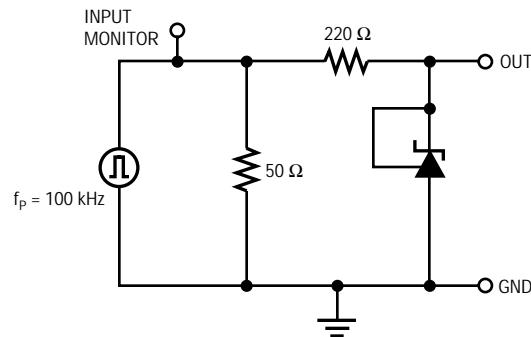
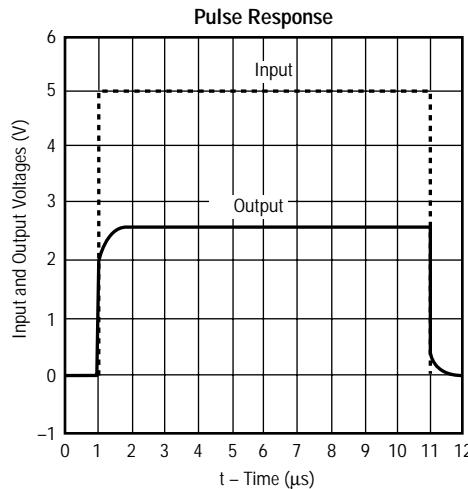


Figure 12

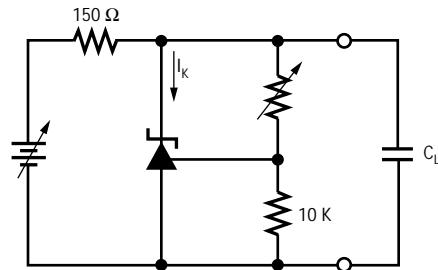
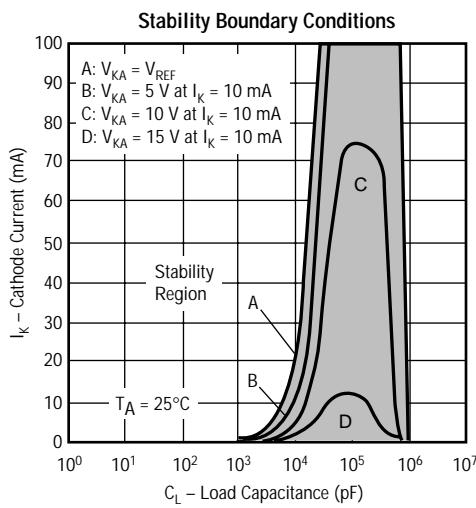


Figure 13